

BAS40 / BAS40-04 / BAS40-05 / BAS40-06

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BAS40 / BAS40-04 / BAS40-05 / BAS40-06

120mA Surface Mount Small Signal Schottky Diodes- 40V

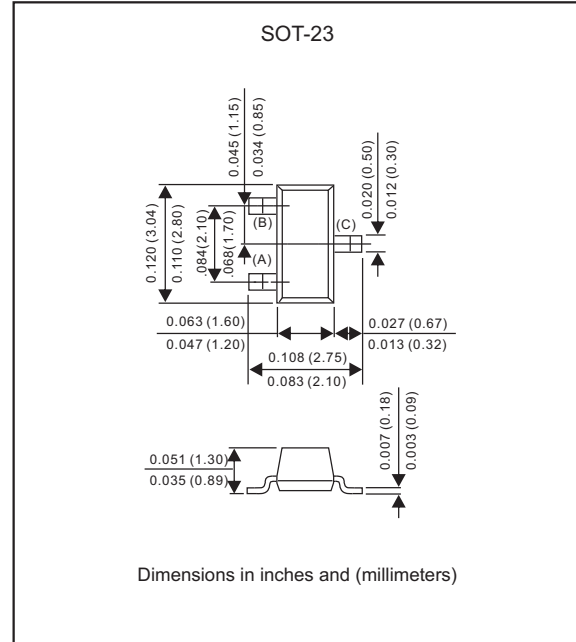
Features

- Low forward current
- Guard ring protected
- Low diode capacitance
- Lead-free parts for green partner, exceeds environmental standards of MIL-STD-19500 /228
- Suffix "-H" indicates Halogen-free part, ex. BAS40-H.

Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram

Package outline



Maximum ratings and Electrical Characteristics (AT T_A=25°C unless otherwise noted)

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Continuous reverse voltage		V _R			40	V
Repetitive Peak forward surge current	tp<1s	I _{FSM}			120	mA
Non-repetitive peak forward current	tp<10ms	I _{FSM}			200	mA
Continuous Forward current		I _F			120	mA
Thermal Resistance	Junction to ambient	R _{θJA}		500		°C/W
Operating junction temperature range		T _J	-55		+125	°C
Storage temperature range		T _{STG}	-55		+125	°C
Forward voltage	I _F = 1 mA	V _F			0.40	V
	I _F = 10 mA	V _F			0.56	V
	I _F = 40 mA	V _F			1.0	V
Reverse current	V _R = 30 V	I _R			1.0	uA
	V _R = 40 V	I _R			10	uA
Diode capacitance	V _R = 0 V, f = 1MHz	C _D			5.0	pF

Rating and characteristic curves for each diode (BAS40 / BAS40-04 / BAS40-05 / BAS40-06)

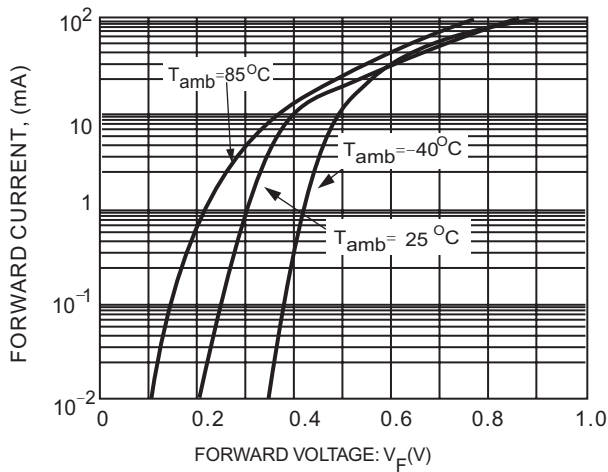


Fig. 1 Forward current as a function of forward voltage; typical values.

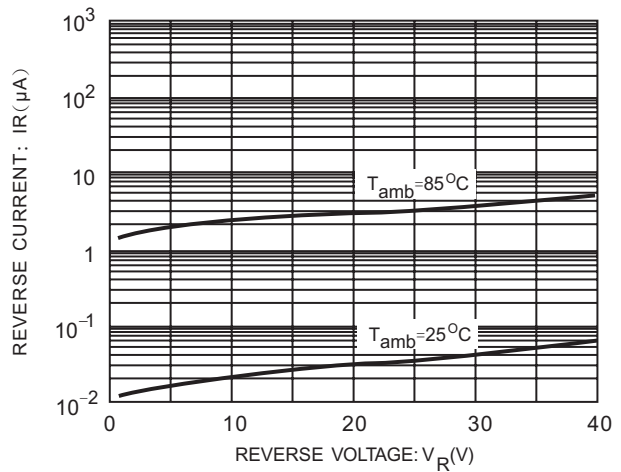


Fig. 2 Reverse current as a function of reverse voltage; typical values.

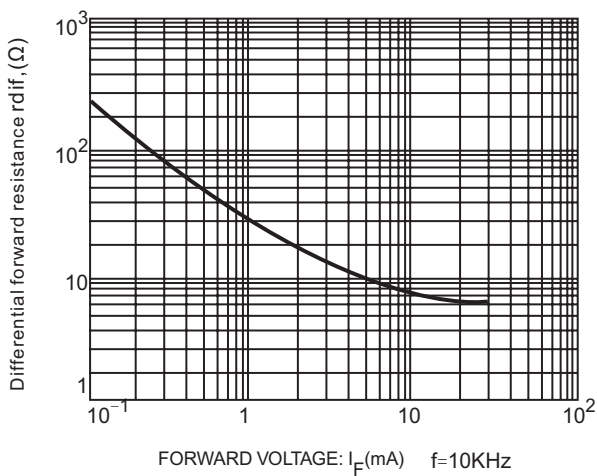


Fig. 3 Differential forward resistance as a function of forward current; typical values.

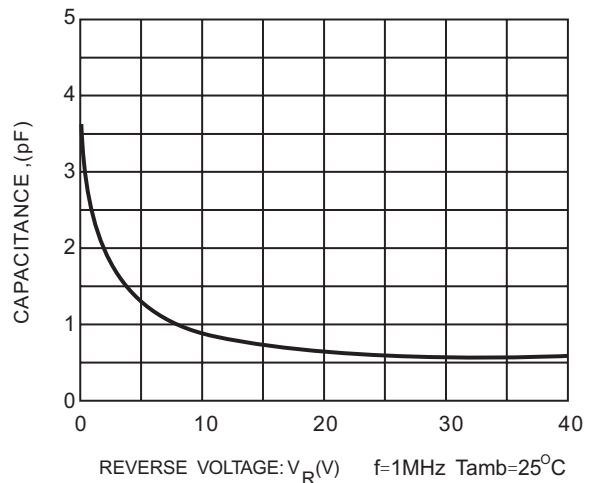


Fig. 4 Diode capacitance as a function of reverse voltage; typical values.

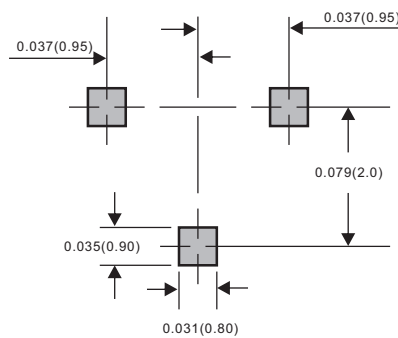
BAS40 / BAS40-04 / BAS40-05 / BAS40-06

Pinning information

Type number	Marking code	Simplified outline	Symbol
BAS40	43, B1		
BAS40-04	44, CB		
BAS40-05	45		
BAS40-06	46, L2		

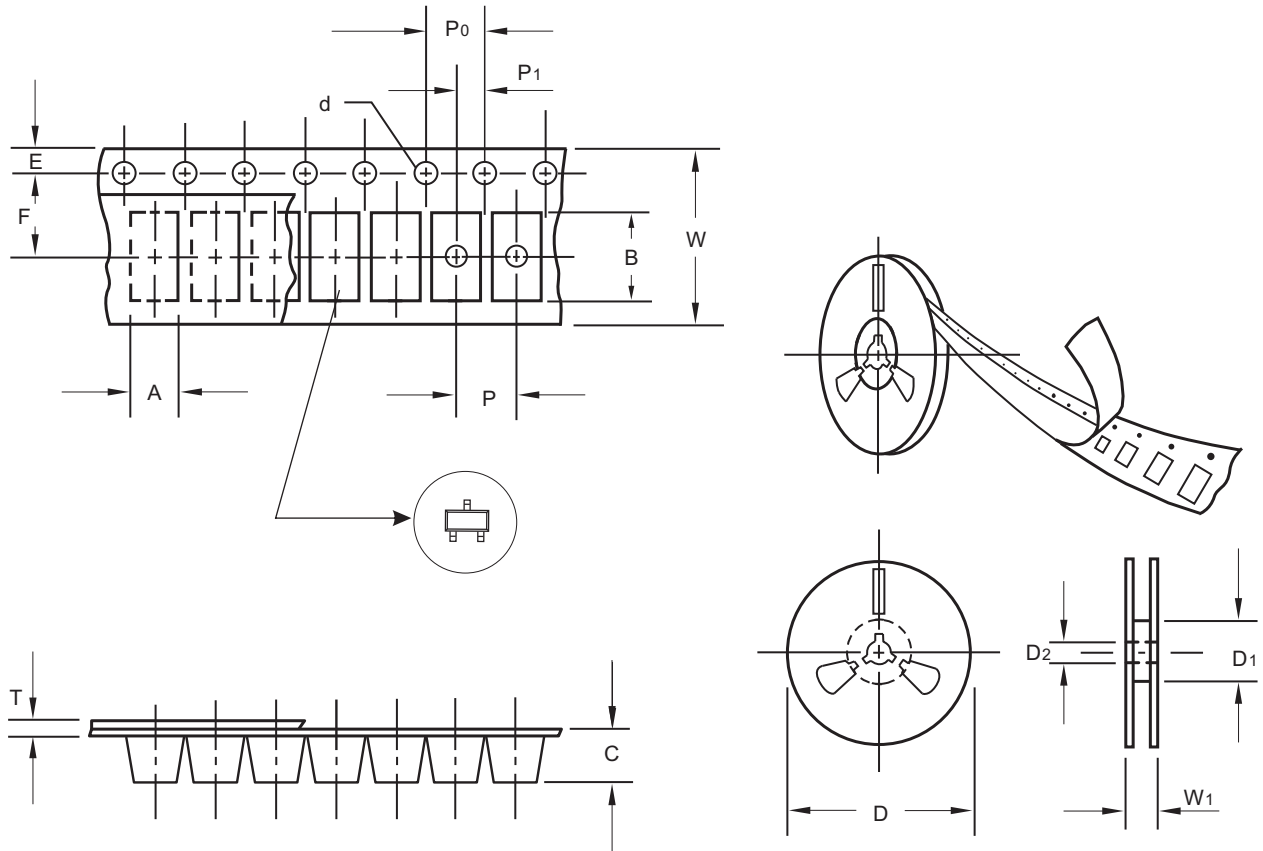
Suggested solder pad layout

SOT-23



Dimensions in inches and (millimeters)

Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	62.00
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

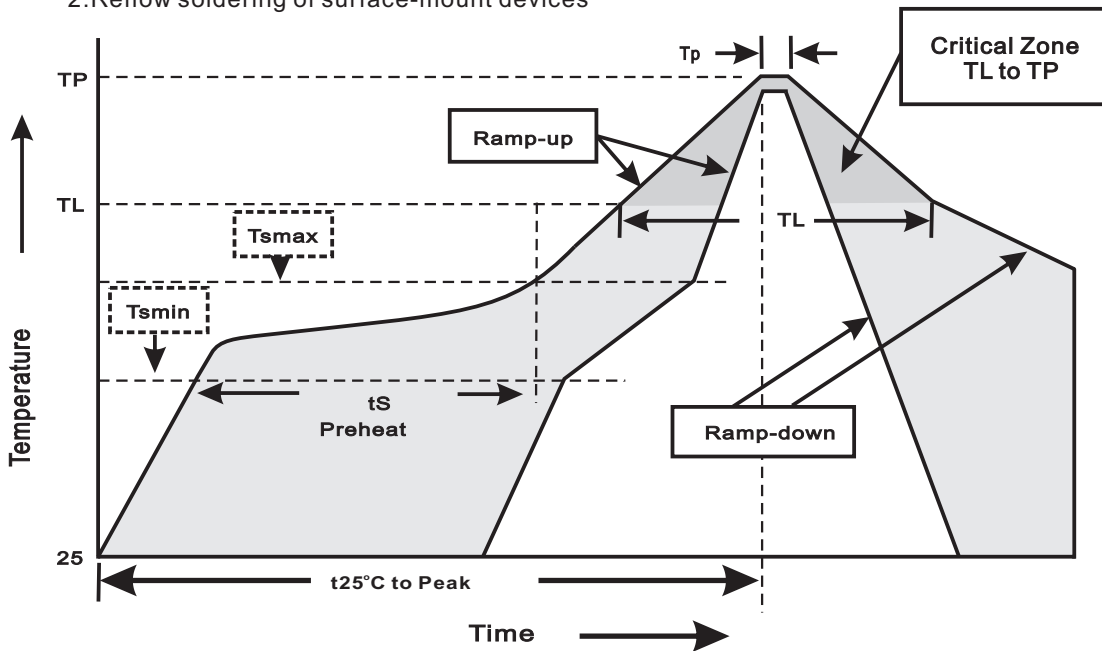
Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*183*123	178	382*262*387	240,000	11.6

Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



3.Reflow soldering

Profile Feature	Soldering Condition
Average ramp-up rate(T _L to T _P)	<3°C/sec
Preheat -Temperature Min(T _{smin}) -Temperature Max(T _{smax}) -Time(min to max)(t _s)	150°C 200°C 60~120sec
T _{smax} to T _L -Ramp-upRate	<3°C/sec
Time maintained above: -Temperature(T _L) -Time(t _L)	217°C 60~260sec
Peak Temperature(T _P)	255°C-0/+5°C
Time within 5°C of actual Peak Temperature(t _P)	10~30sec
Ramp-down Rate	<6°C/sec
Time 25°C to Peak Temperature	<6minutes

BAS40 / BAS40-04 / BAS40-05 / BAS40-06**High reliability test capabilities**

Item Test	Conditions	Reference
1. Solder Resistance	at 260±5°C for 10±2sec. immerse body into solder 1/16"±1/32"	MIL-STD-750D METHOD-2031
2. Solderability	at 245±5°C for 5 sec.	MIL-STD-202F METHOD-208
3. High Temperature Reverse Bias	$V_R=80\%$ rate at $T_J=125^\circ\text{C}$ for 168 hrs.	MIL-STD-750D METHOD-1038
4. Forward Operation Life	Rated average rectifier current at $T_A=25^\circ\text{C}$ for 500hrs.	MIL-STD-750D METHOD-1027
5. Intermittent Operation Life	$T_A = 25^\circ\text{C}$, $I_F = I_o$ On state: power on for 5 min. off state: power off for 5 min. on and off for 500 cycles.	MIL-STD-750D METHOD-1036
6. Pressure Cooker	$15P_{SIG}$ at $T_A=121^\circ\text{C}$ for 4 hrs.	JESD22-A102
7. Temperature Cycling	-55°C to +125°C dwelled for 30 min. and transferred for 5min. total 10 cycles.	MIL-STD-750D METHOD-1051
8. Forward Surge	Peak forward surge current	MIL-STD-750D METHOD-4066-2
9. Humidity	at $T_A=85^\circ\text{C}$, RH=85% for 1000hrs.	MIL-STD-750D METHOD-1021
10. High Temperature Storage Life	at 175°C for 1000 hrs.	MIL-STD-750D METHOD-1031